Se	arcn No	ites

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/622,306	KWAK ET AL.	
Examiner	Art Unit	
Khanh Tran	2611	

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Class	Subclass	Date	Examiner
375	260,267 265,285	11/24/2006	кст
	340-341		
	347-350		
455	273,278.1		

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NO (INCLUDING SEARCH)
	DATE	EXMR
Searches EAST	11/24/2006	кст
Inventor Name Searches		